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Pattern Recognition Based on Straight Line Segments

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1. Introduction

A very common way to represent objects in Pattern Recognition is to extract their features and normalize them into vectors in the space \mathbb{R}^d . With the objects being represented by points in the space \mathbb{R}^d , the distance among them is an intuitive way to compare their similarities and differences and it is used in the most methods in Pattern Recognition. For instance, one of the first and intuitive method in Pattern Recognition that uses this idea is the k -Nearest Neighbor (k -NN). After that, many other methods have emerged using distances, such as Condensed Nearest Neighbor (CNN) (Hart, 1968), Learning Vector Quantization (LVQ) (Kohonen et al., 1988), Nearest Feature Line (NFL) (Li & Lu, 1999), and a new method called Straight Line Segments (SLS) which takes advantage of some good characteristics of LVQ and NFL with low computational complexity (lower than Support Vector Machines) (Ribeiro & Hashimoto, 2006; 2008). This chapter gives a brief discussion about the mentioned methods and details about the SLS method. The next section discusses about the k -NN, CNN, LVQ and NFL methods which are related to the SLS method; Section 3 shows in details the SLS method; Section 4 presents the experimental results using the SLS method; and finally, Section 5 gives the conclusions about the SLS method and presents some future perspectives.

2. Pattern Recognition Based on Distances

This chapter deals only with supervised Pattern Recognition, that is, given a set of labeled objects whose labels were assigned by a tutor. It is desirable that a machine learns how to assign labels to new objects as the tutor does. For simplicity, this work is concentrated on binary classification meaning that there are just two possible values for the labels. For instance, in a system that needs to recognize whether a tumor is malignant or benign, a set of examples (that is, a set of labeled objects) could be a set of tomographic images where a doctor has already assigned a label (malignant or benign) to each one. The Pattern Recognition system needs to learn how to recognize and classify whether a new input image corresponds to a malignant or benign cancer by observing the sample (that is, the set of examples) given by the doctor. To design a system like this, the designer must choose what machine learning is needed to be used in order to have a good classification performance for new objects. A set of machines learning can be represented by a parameterized set of functions $\mathcal{F}_\Lambda = \{f_\alpha : \mathbb{R}^d \mapsto \{0,1\}, \alpha \in \Lambda\}$. Typically, a training algorithm will select the function (or equivalently, the parameter $\alpha \in \Lambda$)

which best classifies new objects (points $x \in \mathbb{R}^d$) by observing the set of examples. Formally a supervised Pattern Recognition system can be defined in the following way (Vapnik, 1999):

1. let $\mathcal{F}_\Lambda = \{f_\alpha : \mathbb{R}^d \mapsto \{0, 1\}, \alpha \in \Lambda\}$ be a set of parameterized functions, where Λ is a set of parameter vectors;
2. let $S_N = \{(x_i, y_i) \in \mathbb{R}^d \times \{0, 1\}, i = 1, 2, \dots, N\}$ be a set of N examples (x_i, y_i) , such that each vector $x_i \in \mathbb{R}^d$ is drawn independently from a fixed but unknown probability distribution $P(x)$; for each input vector x_i , a supervisor returns an output value (label) $y_i \in \{0, 1\}$ according to a conditional probability distribution $P(y | x)$, also fixed but unknown;
3. it is desired to find the parameter $\alpha^* \in \Lambda$ such that the function $f_{\alpha^*} \in \mathcal{F}$ minimizes a certain error or risk function in order to classify (that is, to give labels $y \in \{0, 1\}$) to new query points $x \in \mathbb{R}^d$.

To evaluate any supervised Pattern Recognition system is necessary to define a *loss function* $l_\alpha : \mathbb{R}^d \times \{0, 1\} \mapsto \mathbb{R}$, which represents the penalty given to the machine learning (that is, the function f_α) in case of misclassifying the labeled point (x, y) . The most used loss functions are the absolute and square errors described respectively by Eqs. 1 and 2:

$$l_\alpha(x, y) = |f_\alpha(x) - y|, \quad (1)$$

$$l_\alpha(x, y) = (f_\alpha(x) - y)^2. \quad (2)$$

The loss function gives the penalty for just one misclassification. To obtain the overall behavior of the machine learning it is necessary to compute the *functional risk*. In case of binary classification the functional risk can be the probability of the machine learning making a misclassification. Eq. 3 describes the functional risk.

$$R(\alpha) = \int l_\alpha(x, y) \cdot dP(x, y) \quad (3)$$

However, in most Pattern Recognition problems, the probability $P(x, y)$ is usually unknown and the functional risk is estimated by the *empirical risk*. Let $S_N = \{(x_i, y_i) : x_i \in \mathbb{R}^d \text{ and } y_i \in \{0, 1\}, i \in \{0, 1, \dots, N\}\}$ be a set of N examples, the empirical risk of the machine learning with parameter $\alpha \in \Lambda$ with respect to S_N is defined by:

$$R_{S_N}(\alpha) = \frac{1}{N} \sum_{i=1}^N l_\alpha(x_i, y_i). \quad (4)$$

Since in this chapter we only deal with binary classification, the probability of correct classification can be computed by $1 - R(\alpha)$ and estimated by $1 - R_{S_N}(\alpha)$. After these formal definitions, we give a brief introduction of some supervised Pattern Recognition methods based on distances (or metrics).

2.1 The k -Nearest Neighbor Method

The simplicity and intuitive interpretation are the main qualities of the k -Nearest Neighbor (k -NN) method. According to Devroye et al. (1996), Fix and Hodges presented the k -NN for the first time in 1951. As the name of the method suggests, the k -NN classifies a point $x \in \mathbb{R}^d$ with the class of the majority among the k nearest examples. Usually, k is an odd number to avoid ties in classification. Interesting fact is that Cover & Hart (1967) proved that the asymptotic error rate of k -NN is not greater than twice the Bayes error.

For the most simple implementation of k -NN, the computational complexity is $O(N)$ in both memory use and execution time. Devroye et al. cited several works that reduce the computational time complexity, normally by preprocessing the set of examples (Devroye et al., 1996). For instance, the method proposed in (Friedman et al., 1977) reduces the time complexity to $O(\log(N))$; in another work (Bandyopadhyay & Maulik, 2002) the sample is sorted according to the distance with respect to some reference point. These methods reduce the time complexity and maintain the same precision of the original k -NN, but they still maintain the same memory complexity.

Although the biggest problem of k -NN is the overfitting (that is, the empirical risk can be much lower than the functional risk), the k -NN method is very often used as a reference for other methods, because it does not depend on a lot of parameters and, in many cases, does not depend on the implementation (Jain et al., 2000).

2.2 The Condensed Nearest Neighbor Method

The *Condensed Nearest Neighbor* (CNN) method (Hart, 1968) aims at keeping in the sample just the examples that are relevant for classification in order to achieve a reduction on the computational complexity for both memory use and execution time. The training algorithm for CNN consists in taking out the examples that are not relevant for the classification. Following this idea, many other authors proposed similar methods to reduce the number of examples without loss accuracy. Wilson & Martinez (2000) wrote a good review of these methods and also proposed six more variants.

Although the CNN method tries to reduce the computational time when it is applied to the test phase, as for k -NN, the overfitting issue is still the biggest problem for CNN and derivative methods.

2.3 The Learning Vector Quantization Method

Kohonen et al. (1988) proposed a method based on 1-NN, called *Learning Vector Quantization* (LVQ), in which (i) a predetermined number of processing units, where each processing unit is a reference vector in \mathbb{R}^d that is associated to one class; (ii) an input vector x is classified with the nearest reference vector class. Differently from 1-NN, the reference vectors are not the examples; they are determined by a training algorithm. There are many variants of LVQ, but basically, their training algorithm consists of two main components: (i) a clustering algorithm determines the initial position of the reference vectors, and (ii) an iterative algorithm tries to find the best position for all reference vectors.

After Kohonen's work, many other variations of LVQ have emerged. For instance, Geva & Sitte (1991) proposed a new training algorithm for LVQ called *Decision Surface Mapping*; Hammer & Villmann (2002) presented the *Generalized Relevance Learning Vector Quantization* method which is a training and a feature selection algorithm at the same time. Hammer & Villmann (2002) also compared LVQ to *Support Vector Machines* (SVM). They emphasize two advantages of LVQ over SVM: (i) LVQ is more intuitive and easy to implement; and (ii) the computational complexity of LVQ (on test phase) does not increase with the number of examples as occurs with SVM (Burges, 1998; Hammer et al., 2004).

The computational complexity of LVQ on test phase are directly proportional to the number of reference vectors. Therefore, if N_v is the number of the reference vectors chosen by the user, the computational complexity of LVQ is $O(N_v)$.

2.4 The Nearest Feature Line Method

Li & Lu (1999) presented a method for face recognition called *Nearest Feature Line* (NFL). The main idea behind this method is to define a feature line for each pair of examples of the same class. A new point $x \in \mathbb{R}^d$ is classified as the same class of the nearest feature line. This is a way to virtually increase the information of the sample, interpolating and extrapolating it from a pair of examples. Therefore, each class with N_C examples has $N_C(N_C - 1)/2$ feature lines. If (x_i, y_i) and (x_j, y_j) are two examples in the same class, then $y_i = y_j$. The feature line defined by this pair of examples is denoted by $\overleftrightarrow{x_i x_j}$. The distance from a point x to the feature line $\overleftrightarrow{x_i x_j}$ is defined as (Li & Lu, 1999):

$$d(x, \overleftrightarrow{x_i x_j}) = \|x - p\| \quad (5)$$

where

$$p = x_i + \frac{\langle (x - x_i), (x_j - x_i) \rangle}{\langle (x_j - x_i), (x_j - x_i) \rangle} (x_j - x_i). \quad (6)$$

where $\|a\|$ is the Euclidean norm of $a \in \mathbb{R}^d$ and $\langle a, b \rangle$ is the scalar product between $a \in \mathbb{R}^d$ and $b \in \mathbb{R}^d$.

It was shown that this method has a good classification performance when the number of examples is small and the feature space has a high dimension (Li & Lu, 1999). The disadvantage of this method is its high computational complexity and, depending on the dataset, it could make many misclassifications simply because it exaggerates on interpolation and extrapolation.

Based on NFL, other methods have emerged, for instance, the *Extended Nearest Feature Line* method (Zhou et al., 2004); *Center-based Nearest Neighbor* (Gao & Wang, 2007) and *Rectified Nearest Feature Line* (Du & Chen, 2007). Those methods improved the idea behind the NFL, however they still have a high computational complexity.

3. Pattern Recognition Method Based on Straight Line Segments

Although the Pattern Recognition method based on *Straight Line Segments* (SLS) presented in this section was not designed based on any of the methods described in the previous section, it uses similar ideas. For example, the SLS method uses straight line segments instead of reference vectors of LVQ; and the extremities of the straight line segments do not need to be examples like in NFL and derivatives. Thus, SLS obtains the low computational time complexity of LVQ and uses the interpolation capacity of NFL. So, the SLS method could be considered as an extension of LVQ with some ideas of NFL.

Let $p, q \in \mathbb{R}^{d+1}$. The straight line segment with extremities at p and q , denoted \overline{pq} , is the closed segment of a line in \mathbb{R}^{d+1} with endpoints p and q . More formally,

$$\overline{pq} = \{x \in \mathbb{R}^{d+1} : x = p + \lambda \cdot (q - p), 0 \leq \lambda \leq 1\}. \quad (7)$$

The set of all possible straight line segments is denoted by $\overline{PQ} = \{\overline{pq} : p, q \in \mathbb{R}^{d+1}\}$.

Given a point $x \in \mathbb{R}^d$, the extension of x to \mathbb{R}^{d+1} , denoted by $x_e \in \mathbb{R}^{d+1}$, is the point $x_e = (x, 0)$, that is, the point x is extended to \mathbb{R}^{d+1} by adding one more coordinate with zero value. Given a point $x \in \mathbb{R}^d$ and a straight line segment \overline{pq} , with $p, q \in \mathbb{R}^{d+1}$, the pseudo-distance between x and \overline{pq} is the function $pdist : \mathbb{R}^d \times \overline{PQ} \mapsto \mathbb{R}$ defined as:

$$pdist(x, \overline{pq}) = \frac{dist(x_e, p) + dist(x_e, q) - dist(p, q)}{2}, \tag{8}$$

where $dist(a, b)$ denotes the Euclidean distance between points $a \in \mathbb{R}^{d+1}$ and $b \in \mathbb{R}^{d+1}$. Note that $pdist$ is not the Euclidean distance between a point $x \in \mathbb{R}^d$ and a straight line segment \overline{pq} , but it satisfies the following reasonable axioms:

1. If $p = q$, then $pdist(x, \overline{pq}) = dist(x, p)$.
2. If $x \in \overline{pq}$, then $pdist(x, \overline{pq}) = 0$.
3. If $x \notin \overline{pq}$, then $pdist(x, \overline{pq}) > 0$.

Let \mathbb{L} be the collection of all possible sets of straight line segments, that is, $\mathbb{L} = \{L : L \subseteq \overline{PQ}\}$. Given two sets the straight line segments, L_0 and L_1 , (that is, $L_0, L_1 \in \mathbb{L}$), if $\mathcal{L} = (L_0, L_1) \in \mathbb{L}^2$, then we define the *discriminant function* $T : \mathbb{R}^d \times \mathbb{L}^2 \mapsto \mathbb{R}$ as

$$T(x, \mathcal{L}) = \lim_{\epsilon \rightarrow 0} \left(\sum_{\overline{pq} \in L_1} \frac{1}{pdist(x, \overline{pq}) + \epsilon} - \sum_{\overline{pq} \in L_0} \frac{1}{pdist(x, \overline{pq}) + \epsilon} \right). \tag{9}$$

Finally, given a pair of sets of straight line segments $\mathcal{L} = (L_0, L_1) \in \mathbb{L}^2$, we define the *classification function* $y_{\mathcal{L}} : \mathbb{R}^d \mapsto [0, 1]$ as

$$y_{\mathcal{L}}(x) = \frac{1}{1 + e^{-g \cdot T(x, \mathcal{L})}}, \tag{10}$$

where g is a positive real constant. Note that, if $\exists \overline{p_a q_a} \in L_1$ such that $pdist(x, \overline{p_a q_a}) \rightarrow 0$ and $pdist(x, \overline{p_b q_b}) \gg 0$ such that $\forall \overline{p_b q_b} \in L_0$, then the first term in Eq. 9 tends to $+\infty$. Consequently $T(x, \mathcal{L}) \rightarrow +\infty$ and, therefore, $y_{\mathcal{L}}(x) \rightarrow 1$. On the other hand, if $\exists \overline{p_b q_b} \in L_0$ such that $pdist(x, \overline{p_b q_b}) \rightarrow 0$ and $pdist(x, \overline{p_a q_a}) \gg 0$ such that $\forall \overline{p_a q_a} \in L_1$, then the second term in Eq. 9 tends to $-\infty$. Consequently $T(x, \mathcal{L}) \rightarrow -\infty$ and, therefore, $y_{\mathcal{L}}(x) \rightarrow 0$. Furthermore, when both terms in Eq. 9 are equal, $T(x, \mathcal{L}) \rightarrow 0$ and $y_{\mathcal{L}}(x) \rightarrow 0.5$. Thus, in the case of binary classification, the class of a point $x \in \mathbb{R}^d$ can be obtained by thresholding the function $y_{\mathcal{L}}(x)$ at level 0.5 in the following way: the class of point x is 0 if and only if $y_{\mathcal{L}}(x) \leq 0.5$. Therefore, the decision boundary that separates classes 0 from 1 depends on the choice of pair of sets of straight line segments $\mathcal{L} = (L_0, L_1) \in \mathbb{L}^2$. Observe that the SLS method has a difference of all other methods mentioned in previous section: while points $x \in \mathbb{R}^d$, the straight line segments are in \mathbb{R}^{d+1} . It gives more flexibility for the decision boundary.

Although this chapter does not deal with regression, in order to show how the classification function $y_{\mathcal{L}}(x)$ can be versatile, we illustrate that $y_{\mathcal{L}}(x)$ can be used to approximate four different functions $f_i : [0, 1] \mapsto [0, 1]$, $i \in \{1, 2, 3, 4\}$, with only a few straight line segments. The four functions are the following:

$$f_1(x) = \frac{1}{4} + \frac{x}{2}; 0 \leq x \leq 1; \tag{11}$$

$$f_2(x) = \begin{cases} 1 & 0 \leq x < 0.25 \\ 0 & 0.25 \leq x < 0.5 \\ 1 & 0.5 \leq x < 0.75 \\ 0 & 0.75 \leq x \leq 1; \end{cases} \tag{12}$$

$$f_3(x) = 0.5 + 0.4 \sin(2 \cdot \pi \cdot x); 0 \leq x \leq 1; \tag{13}$$

$$f_4(x) = \begin{cases} 0.5 + 1.8x & 0 \leq x < 0.25 \\ 1.4 - 1.8x & 0.25 \leq x < 0.75 \\ -1.3 + 1.8x & 0.75 \leq x \leq 1; \end{cases} \tag{14}$$

In Figure 1, we show the plots of the approximation of f_i using the function $y_{\mathcal{L}}^i(x)$. The functions $f_i(x)$, $i \in \{1, 2, 3, 4\}$, are represented by red lines; while the corresponding approximation functions $y_{\mathcal{L}}^i(x)$ are represented by blue lines; the straight line segments in L_0 are represented with circles at the extremities, and the straight line segments in L_1 with \times at the extremities. Note that the four functions are quite different and the approximations are very good (in the domain $[0, 1]$). Observe that, for only function $f_4(x)$, it is necessary to use two straight line segments for each class, where one of them is degenerated into a point; in all other functions, just one straight line segment for each class is sufficient to make a good approximation. In Table 1, we provide the obtained empirical risk of these approximations.

| Function | absolute error | squared error |
|----------|----------------|---------------|
| $f_1(x)$ | 0.002011 | 0.000005 |
| $f_2(x)$ | 0.000367 | 0.000011 |
| $f_3(x)$ | 0.008240 | 0.000090 |
| $f_4(x)$ | 0.009094 | 0.000120 |

Table 1. Empirical risk of the approximations of the functions f_i .

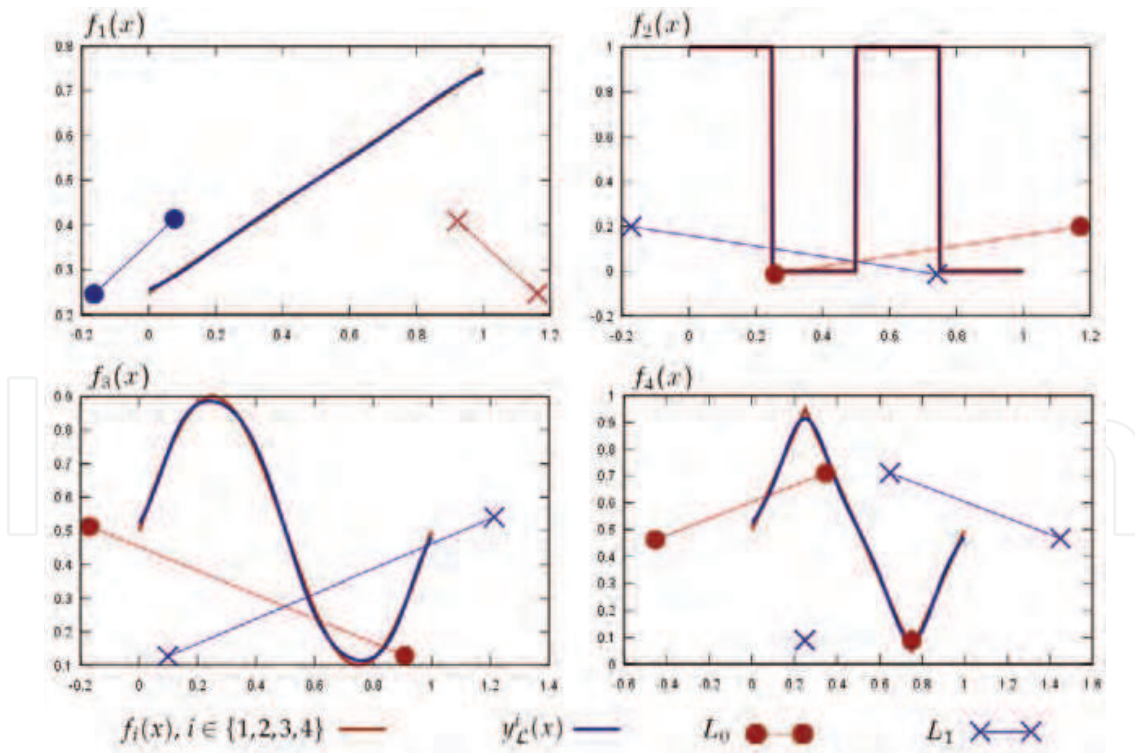


Fig. 1. Plots of the functions $f_i(x)$ and the corresponding approximations $y_{\mathcal{L}}^i(x)$, $i = 1, 2, 3, 4$, with the respective straight line segments.

3.1 Training Algorithm

The objective of the training algorithm is to find two sets of straight line segments that minimize the functional risk (Eq. 3). However, usually it is impossible to compute the functional risk, since the probability distribution is unknown in many situations. Therefore, the functional risk must be estimated by the empirical risk (Eq. 4). In this way, the training algorithm is based on the empirical risk minimization principle (Vapnik, 1999). More formally, given a sample S_N , the training algorithm must find two sets of straight line segments, L_0 and L_1 , that minimize the empirical risk $R_{S_N}(\alpha)$, where the parameter vector α is defined by the positions of the straight line segments in both L_0 and L_1 . The training algorithm is divided into two phases:

1. **Placing Algorithm:** In this phase, a heuristic pre-allocates (initializes) the straight line segments.
2. **Tuning Process:** In this phase, the straight line segments are moved from the initial position driven by an optimization algorithm that tries to minimize the empirical risk.

3.2 Placing Algorithm

The first phase of the training algorithm consists of pre-allocating (that is, finding the initial positions of) the straight line segments which will be tuned later. The **Placing Algorithm** (see below) is based on the fact that the points in the region of the feature space that are near to the straight line segments belonging to L_0 (respectively, L_1) make the function $y_{\mathcal{L}}(x)$ tend to 0 (respectively, 1). Thus the first step of the Placing algorithm is to split the sample S_N into two groups of point sets X_0 and X_1 (see Lines 4 and 5 of the Placing algorithm). Group $X_0 \subseteq \mathbb{R}^d$ will initialize the straight line segments of L_0 ; while group $X_1 \subseteq \mathbb{R}^d$ will initialize the straight line segments of L_1 . At Line 9, the k -means clustering algorithm (Duda et al., 2001; Jain et al., 1999) is applied to each group X_j ($j = 0, 1$) in order to find k clusters $C_0, C_1, \dots, C_{k-1} \subseteq X_j$, with their corresponding centers $c_0, c_1, \dots, c_{k-1} \in \mathbb{R}^d$. After that, the k -means clustering is applied again to each cluster in C_i ($i = 0, 1, \dots, k-1$) using $k = 2$ (Line 11 of the Placing algorithm). The two centers d_0 and d_1 returned by 2-means determines the extremities of a straight line segment for each cluster C_i . Since we have k clusters C_i for each class, we have in total k straight line segments for each class. After that, each extremity of the straight line segments is extended in one extra dimension and the value of the corresponding extra coordinate is initially set to 1 for all extremities (see Lines 12 to 14). This value will be adjusted in the tuning process. Although any other clustering algorithm could be used in the Placing algorithm, the k -means was chosen as clustering algorithm because it is simple to implement and has fast convergence (Duda et al., 2001; Jain et al., 1999).

- 1: PLACING($S_N, nSLS$)
- 2: **Input:** A sample $S_N = \{(x_i, y_i) : x_i \in \mathbb{R}^d, y_i \in \{0, 1\}, i = 1, 2, \dots, N\}$ and $nSLS$ (number of straight line segments for each set L_0 and L_1).
- 3: **Output:** Two sets of straight line segments L_0 and L_1 (with $nSLS$ elements in each one).
- 4: $X_0 \leftarrow \{x_i \in \mathbb{R}^d : (x_i, y_i) \in S_N \text{ and } y_i = 0\}$;
- 5: $X_1 \leftarrow \{x_i \in \mathbb{R}^d : (x_i, y_i) \in S \text{ and } y_i = 1\}$;
- 6: **for** $j \leftarrow 0$ to 1 **do**
- 7: $L_j \leftarrow \emptyset$;
- 8: $k \leftarrow nSLS$;
- 9: $[(c_0, C_0), \dots, (c_{k-1}, C_{k-1})] \leftarrow k\text{-means}(X_j)$;
- 10: **for** $i \leftarrow 0$ to $k-1$ **do**


```

11:     $[(d_0, D_0), (d_1, D_1)] \leftarrow 2\text{-means}(C_i);$ 
12:     $\ell \leftarrow 1;$ 
13:     $p \leftarrow (d_0, \ell);$ 
14:     $q \leftarrow (d_1, \ell);$ 
15:     $L_j \leftarrow L_j \cup \overline{pq};$ 
16:  end for
17: end for
18: return  $L_0, L_1;$ 

```

The computational complexity of k -means is $O(N \cdot d \cdot k \cdot i)$, where i is the number of interactions, typically less than N . As k -means is applied twice to the sample, the computational complexity for placing is $O(N \cdot d \cdot k \cdot i)$. Considering $i \ll N$, with $k = nSLS$ at Line 9 and $k = 2$ at Line 11, it is possible to conclude that the computational complexity of Placing Algorithm is $O(N \cdot d \cdot nSLS)$ (Lingras & Yao, 2002).

3.3 Tuning the Straight Line Segments

The natural way to find the positions of the straight line segments that minimize the empirical risk (Eq. 4) is to find a point where its derivative is equal to zero. Since this calculation is not analytically feasible, we opted to use the gradient descent method. Since the gradient descent does not guarantee the global minimum, the final positions of the straight line segments will depend on their initial position computed previously by the Placing algorithm. In this way, the Placing algorithm is very important, because it can make the second part of the training algorithm to converge to a “good” local solution.

3.4 Gradient Descent

The optimization gradient descent method consists of moving in small steps the parameters (the vector α) in same direction of the gradient of the objective function in order to minimize (or maximize) its value (Michie et al., 1973).

Each displacement of vector α is proportional to γ which is a real positive number. If γ is too big, the displacement can be exaggerated and the empirical risk can increase instead of decrease. On the other hand, if γ was too small, the minimization process of the empirical risk can be too slow. It is possible to implement the gradient descent using a constant value for γ , but in this case, it is necessary to choose small values for γ to avoid exaggerated moves. Because of that, we use a dynamic γ . For each iteration, if the empirical risk decreases, γ increases proportionally to $1 + \gamma_{inc}$ (Line 11 of the GradDesc algorithm). On the other hand, if the iteration increases the empirical risk, the value of γ decreases proportionally to γ_{dec} (Line 15 of the GradDesc algorithm). Although the value of γ is updated dynamically during the training process, it must not be exaggerated in order to avoid the instability of the initial steps of tuning process. Empirically, we observed that γ stabilizes around 0.1, so this value is adopted for the initial γ . To compute the γ value dynamically it is interesting not to change the value of γ too much when the empirical risk is decreasing, and it is also interesting to decrease the value of γ quickly when the iteration increases the empirical risk. Therefore we set $\gamma_{inc} = 0.1$ and $\gamma_{dec} = 0.5$.

1: GRADDESC ($\alpha, I_{max}, I_{min}, \gamma_{ini}, \gamma_{inc}, \gamma_{dec}, Disp_{min}, R_{min}$);

2: **Input:** The vector α that must be optimized; the maximum number I_{max} of iterations; the minimum number I_{min} of iterations; the initial value γ_{ini} for γ ; the increasing rate γ_{inc} for γ ; the decreasing rate γ_{dec} for γ ; the minimum displacement $Disp_{min}$; and finally the minimum empirical risk R_{min} .

```

3: Output: the vector  $\alpha$  with optimized values.
4:  $\alpha_{best} \leftarrow \alpha; \gamma \leftarrow \gamma_{init}; R0 \leftarrow R_{S_N}(\alpha); I \leftarrow 0;$ 
5: repeat
6:    $dR \leftarrow \nabla_{\alpha} R_{S_N}(\alpha);$ 
7:    $\alpha \leftarrow \alpha - \gamma \cdot dR;$ 
8:    $Disp \leftarrow |\gamma \cdot dR| / \sqrt{\dim(\alpha)};$ 
9:    $R1 \leftarrow R_{S_N}(\alpha);$ 
10:  if  $R0 \geq R1$  then
11:     $\gamma \leftarrow \gamma \cdot (1 + \gamma_{inc});$ 
12:     $\alpha_{best} \leftarrow \alpha;$ 
13:     $R0 \leftarrow R1;$ 
14:  else
15:     $\gamma \leftarrow \gamma \cdot \gamma_{dec};$ 
16:     $\alpha \leftarrow \alpha_{best};$ 
17:  end if
18:   $I \leftarrow I + 1;$ 
19: until  $((I > I_{min}) \text{ and } ((I > I_{max}) \text{ or } (Disp < Disp_{min}) \text{ or } (R1 < R_{min})));$ 
20: return  $\alpha_{best};$ 

```

Four conditions are used to stop the gradient descent process. First, the condition $I > I_{min}$ guaranties a minimum number I_{min} of iterations. Secondly, the number of iterations can not exceed I_{max} to guarantee that the algorithm will stop; thirdly, if the displacement of the parameters is smaller than $Disp_{min}$, it may mean that the parameter vector has achieved a local minimum; and the fourth criterion is useful when it is known what is the minimal empirical risk in order to avoid overfitting.

Note that the value of displacement $Disp$ is computed using $|\gamma \cdot dR|$ and is divided by the square root of the dimension of vector α (see Line 8). This division normalizes the displacement with respect to the number of parameters. Thus, the value for $Disp_{min}$ is normalized for all optimization problem. Empirically we observed that with $Disp_{min} = 0.001$ the empirical risk is stabilized.

3.5 The Proposed Training Algorithm

Before tuning of the extremities of the initial straight line segments (that is, adjusting their positions), it is necessary to determine the best initial value ℓ for the last coordinate of all extremities of the straight line segments (the value of the variable ℓ which was initialized with 1 in the Placing algorithm) and for the constant g (see Eq. 10).

In previous versions of the training algorithm, the initial value of ℓ was determined by the standard deviation of the examples in the sample (Ribeiro & Hashimoto, 2006; 2008). This heuristic aims at making the initial displacement of the last coordinate proportional to the examples dispersion. Also, in a previous version, the value of g was also chosen by a heuristic that makes the values of $y_{\mathcal{L}}(x)$ have a uniform distribution (Ribeiro & Hashimoto, 2008). This way, low and high values of g is prevented, which make $y_{\mathcal{L}}(x)$ tend to 0.5 and to 0 or 1, respectively. Although those heuristics work well, they do not consider the empirical risk. So, here, we have applied the gradient descent to find better values for both ℓ and g .

In our case we desire to minimize the empirical risk. The training algorithm applies the gradient descent twice: first to find the best values for ℓ and g ; and, secondly to find the best position for all extremities of all straight line segments (of course, including all their last coordinates).

- 1: TRAINING ($S_N, nSLS, I_{max}, I_{min}, \gamma_{ini}, \gamma_{inc}, \gamma_{dec}, Disp_{min}, R_{min}$);
- 2: **Input:** A sample $S_N = \{(x_i, y_i) : x_i \in \mathbb{R}^d; y_i \in \{0, 1\}, i = 1, 2, \dots, N\}$ and $nSLS$ (number of straight line segments for each set L_0 and L_1). The other inputs are: the maximum number I_{max} of iterations; the minimum number I_{min} of iterations; the initial value γ_{ini} for γ ; the increasing rate γ_{inc} for γ ; the decreasing rate γ_{dec} for γ ; the minimum displacement $Disp_{min}$; and finally the minimum empirical risk R_{min} .
- 3: **Output:** two sets of straight line segments L_0 and L_1 .
- 4: $[L_0, L_1] \leftarrow \text{Placing}(S_N, nSLS)$;
- 5: $g \leftarrow 1$;
- 6: $\alpha_1 \leftarrow \text{Vectorize}(g, \ell)$;
- 7: $(g, \ell) \leftarrow \text{GradDesc}(\alpha_1, I_{max}, I_{min}, \gamma_{ini}, \gamma_{inc}, \gamma_{dec}, Disp_{min}, R_{min})$;
- 8: $\alpha_2 \leftarrow \text{Vectorize}(L_0, L_1)$;
- 9: $(L_0, L_1) \leftarrow \text{GradDesc}(\alpha_2, I_{max}, I_{min}, \gamma_{ini}, \gamma_{inc}, \gamma_{dec}, Disp_{min}, R_{min})$;
- 10: **return** L_0, L_1 and g ;

The parameters g and ℓ define the vector α_1 , where g is a positive real number that defines how "smooth" the sigmoid $y_{\mathcal{L}}(x)$ will be with respect to $T(x, \mathcal{L})$; and ℓ is the value for the last coordinate of all straight line segments that is initially equal to 1 for all segments.

The function $\text{Vectorize}(g, \ell)$ returns the following parameter vector α_1 :

$$\alpha_1 = \begin{bmatrix} g \\ \ell \end{bmatrix}. \quad (15)$$

The function $\text{Vectorize}(L_0, L_1)$ returns the parameter vector α_2 for the second gradient descent whose coordinates are the extremities of each straight line segment (including all their last coordinates):

$$\alpha_2 = \begin{bmatrix} p_h^{j,k} \\ \vdots \\ q_h^{j,k} \\ \vdots \end{bmatrix}, \quad j \in \{0, 1\}, \quad k \in \{1, \dots, |L|\}, \quad h \in \{1, \dots, d+1\}, \quad (16)$$

where $L = |L_0|$ (assuming that $|L_0| = |L_1|$) and $p_h^{j,k}$ is the value of the h -th coordinate of the extremity \mathbf{p} of the k -th straight line segment $\overline{\mathbf{p}_k \mathbf{q}_k}$ of L_j . The other extremity \mathbf{q} of $\overline{\mathbf{p}_k \mathbf{q}_k} \in L_j$ is represented in analogous way. The function $\text{vectorize}(L_0, L_1)$ returns the vector α_2 as described in Eq. 16. We should remark that after the application of the second gradient descent, the last coordinates of all straight line segments are not equal anymore.

We use the square error (Eq. 2) as the loss function. Thus, the empirical risk is defined by Eqs. 17 and 18. To simplify the notation, we will omit the parameters of some functions such as: $T_i = T(x_i, \mathcal{L})$, $y_{\mathcal{L}} = y_{\mathcal{L}}(x_i)$ and $pdist_{i,k}^j = pdist(x_i, L_k^j)$. In the following, we present the calculations for the gradient of $R_{S_N}(\alpha)$, where $\alpha = \alpha_2$, that is, $\nabla_{\alpha_2} R_{S_N}$. Let

$$err_i(y_{\mathcal{L}}) = y_{\mathcal{L}}(x_i) - y_i \quad \text{and} \quad (17)$$

$$R_{S_N}(\alpha) = \frac{1}{N} \sum_{i=1}^N [err_i(y_{\mathcal{L}})]^2. \quad (18)$$

The gradient $\nabla_{\alpha_2} R_{S_N}$ is defined for $j = \{0, 1\}$, $k = \{1, \dots, |L|\}$ and $h = \{1, \dots, d+1\}$ as:

$$\nabla_{\alpha_2} R_{S_N}(\alpha_2) = \begin{bmatrix} \frac{\partial R_{S_N}}{\partial p_h^{j,k}} \\ \vdots \\ \frac{\partial R_{S_N}}{\partial q_h^{j,k}} \\ \vdots \end{bmatrix}, \tag{19}$$

where

$$\frac{\partial R_{S_N}}{\partial p_h^{j,k}} = \frac{1}{N} \sum_{i=1}^n 2 \cdot err_i \frac{g}{e^{g \cdot T_i} + e^{-g \cdot T_i} + 2} \frac{(-1)^j}{(pdist_{i,k}^j + \epsilon)^2}. \tag{20}$$

$$\left(\frac{p_h^{j,k} - x_{i,h}}{2 \cdot dist(x_i, p^{j,k})} - \frac{p_h^{j,k} - q_h^{j,k}}{2 \cdot dist(p^{j,k}, q^{j,k})} \right). \tag{21}$$

The calculations of the parameters for the first gradient are g and ℓ . The value for the last coordinate of all straight line segments is set $p_{d+1}^{j,k} = q_{d+1}^{j,k} = \ell$ (that is, $p_{d+1}^{j,k}$ and $q_{d+1}^{j,k}$ are replaced with ℓ in the empirical risk R_{S_N} making it as a function of g and ℓ). Then, we have:

$$\nabla_{\alpha_1} R_{S_N}(\alpha_1) = \begin{bmatrix} \frac{\partial R_{S_N}}{\partial g} \\ \frac{\partial R_{S_N}}{\partial \ell} \end{bmatrix}, \tag{22}$$

$$\frac{\partial R_{S_N}}{\partial g} = \sum_{i=1}^N \frac{2 \cdot err_i \cdot T_i \cdot e^{g \cdot T_i}}{e^{2g \cdot T_i} + 2e^{g \cdot T_i} + 1} \text{ and} \tag{23}$$

$$\frac{\partial R_{S_N}}{\partial \ell} = \sum_{j=0}^1 \sum_{k=1}^{|L_j|} \left(\frac{\partial R_{S_N}}{\partial p_{d+1}^{j,k}} + \frac{\partial R_{S_N}}{\partial q_{d+1}^{j,k}} \right). \tag{24}$$

By the beginning of the first gradient, the last coordinates $p_{d+1}^{j,k} = q_{d+1}^{j,k} = 1$. Between the first gradient and the beginning of the second gradient, the last coordinates $p_{d+1}^{j,k} = q_{d+1}^{j,k} = \ell$ for all straight line segments. Finally, after the second gradient each last coordinate can have different values among them.

The time complexity for the *Training* algorithm is the sum of the complexity of *Placing* Algorithm plus twice the complexity of *GradDesc* Algorithm, that is $O(N \cdot d \cdot nSLS) + 2O(N \cdot d \cdot nSLS \cdot I_{max})$, which is equal to $O(N \cdot d \cdot nSLS \cdot I_{max})$.

To avoid overfitting and unnecessary increasing of computational time complexity, the best choice is to use a minimum number of straight line segments (for each class) for which the SLS method still has a good classification performance.

4. Experimental Results

In this section we describe the experiments we performed in order to evaluate the SLS method and compare it with other methods. For that, the experiments were divided into two parts: the first one uses artificial data to evaluate the behavior of the SLS method; while the second one uses public datasets to analyse the SLS method with real applications and compare our results with the results obtained by other methods.

4.1 Artificial Data

The artificial data for each class $C \in \{0, 1\}$ were generated using probability distributions associated to the density function defined by the sum of M two dimensional normal density functions as shown in Eq. 25:

$$p(x, y = C) = \sum_{i=1}^M P_i^C \cdot \text{Normal}(x, \mu_i^C, \Sigma_i^C), \quad (25)$$

where $\mu_i^C \in \mathbb{R}^2$ is the center of the normal density function, Σ_i^C is the 2×2 covariance matrix and P_i^C is a real number such that $\sum_{i=1}^M P_i^C = 1$. In general, each covariance matrix Σ^C is positive semidefinite matrix and has the following form:

$$\begin{pmatrix} (\sigma_1)^2 & \rho\sigma_1\sigma_2 \\ \rho\sigma_1\sigma_2 & (\sigma_2)^2 \end{pmatrix}, \quad (26)$$

where ρ is the correlation between the two random variables x_1 and x_2 , and σ_j , for $j = 1, 2$, is the standard deviation of x_j . We designed four probability density functions called *Simple*, *distX*, *distS* and *DistF*. Each probability density function (pdf) is defined as follows:

Simple pdf:

$$\begin{aligned} P_1^0 &= 1.0 & P_1^1 &= 1.0 \\ \mu_1^0 &= (0.6, 0.6) & \mu_1^1 &= (0.4, 0.4) \\ \Sigma_1^0 &= \begin{pmatrix} 0.010 & -0.009 \\ -0.009 & 0.010 \end{pmatrix} & \Sigma_1^1 &= \begin{pmatrix} 0.010 & 0.009 \\ 0.009 & 0.010 \end{pmatrix} \end{aligned} \quad (27)$$

DistX pdf:

$$\begin{aligned} P_1^0 &= P_2^0 = 0.5 & P_1^1 &= P_2^1 = 0.5 \\ \mu_1^0 &= (0.25, 0.25) & \mu_1^1 &= (0.25, 0.75) \\ \mu_2^0 &= (0.75, 0.75) & \mu_2^1 &= (0.75, 0.25) \\ \Sigma_i^C &= \begin{pmatrix} 0.04 & 0.00 \\ 0.00 & 0.04 \end{pmatrix}, & C &\in \{0, 1\} \text{ and } i \in \{1, 2\} \end{aligned} \quad (28)$$

DistS pdf:

$$\begin{aligned} P_1^0 &= P_2^0 = 0.5 & P_1^1 &= P_2^1 = 0.5 \\ \mu_1^0 &= (0.4, 0.4) & \mu_1^1 &= (0.6, 0.2) \\ \mu_2^0 &= (0.4, 0.8) & \mu_2^1 &= (0.6, 0.6) \\ \Sigma_i^C &= \begin{pmatrix} 0.02 & 0.00 \\ 0.00 & 0.01 \end{pmatrix}, & C &\in \{0, 1\} \text{ and } i \in \{1, 2\} \end{aligned} \quad (29)$$

DistF pdf:

$$\begin{aligned}
 P_1^0 &= 0.574 & P_1^1 &= 0.574 \\
 P_2^0 &= P_3^0 = 0.213 & P_2^1 &= P_3^1 = 0.213 \\
 \mu_1^0 &= (0.125, 0.5) & \mu_1^1 &= (0.875, 0.5) \\
 \mu_2^0 &= (0.5, 0.375) & \mu_2^1 &= (0.5, 0.125) \\
 \mu_3^0 &= (0.5, 0.875) & \mu_3^1 &= (0.5, 0.625) \\
 \Sigma_1^C &= \begin{pmatrix} 0.010 & 0.000 \\ 0.000 & 0.040 \end{pmatrix} & \Sigma_2^C &= \begin{pmatrix} 0.012 & 0.000 \\ 0.000 & 0.010 \end{pmatrix} \\
 \Sigma_3^C &= \begin{pmatrix} 0.012 & 0.000 \\ 0.000 & 0.010 \end{pmatrix}, & C \in \{0, 1\}. &
 \end{aligned}
 \tag{30}$$

Figure 2 shows four graphics, each one representing one of the probability density functions. In Figure 3, there are four samples with 800 examples, each one drawn from one of the probability distributions associated with the 4 probability density functions.

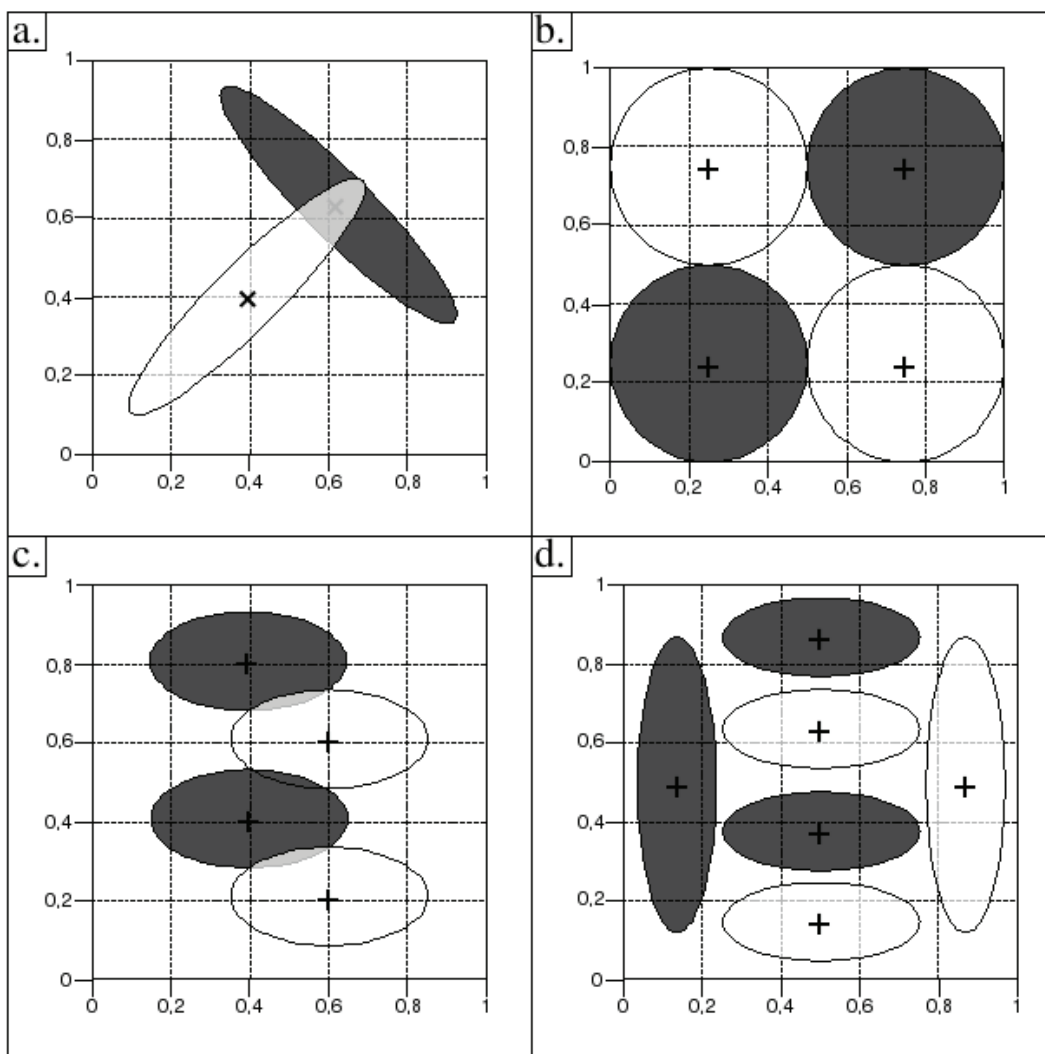


Fig. 2. Representation of the probability density functions: a) *Simple*, b) *DistX*, c) *DistS* and d) *DistF*.

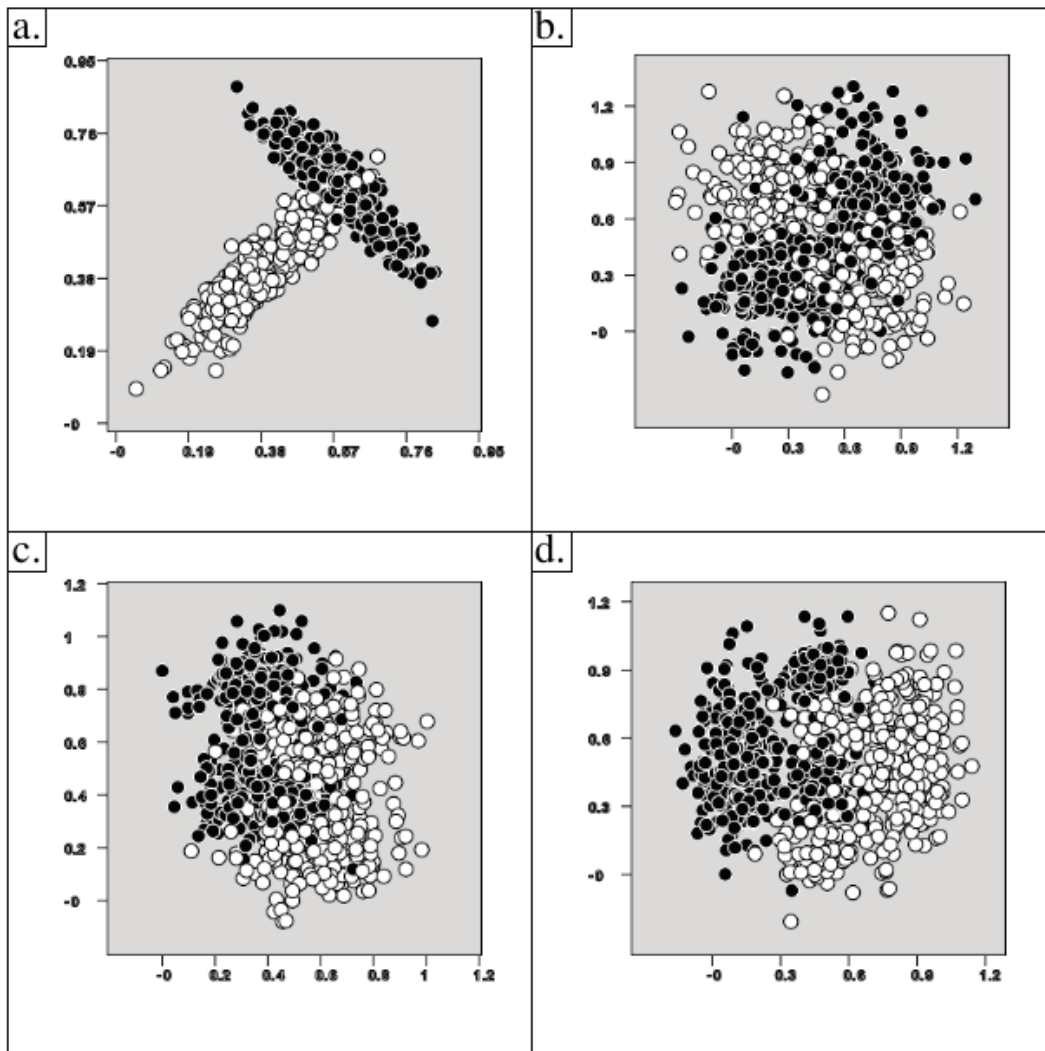


Fig. 3. Samples drawn from the probability distributions with 800 examples: a) *Simple*, b) *DistX*, c) *DistS* and d) *DistF*.

Since the probability density function is known, it is possible to compute the functional risk $R(\alpha)$ (see Eq. 3) of the SLS and Bayes classifiers (Duda et al., 2001). Consequently, it is possible to compute the actual probability of correct classification, that is $1 - R(\alpha)$, for both classifiers. For that, we used the numerical integration considering the values for $x \in \mathbb{R}^2$ inside the rectangle defined by the corners $(-0.5, -0.5)$ and $(1.5, 1.5)$. Inside this rectangle, there are more than 99% of examples for all probability density functions. The numerical integration was done using 160 000 points. The probability of correct classification for Bayes classifier for each probability density function is shown in Table 2.

| Probability Density Function | Bayes (%) |
|------------------------------|-----------|
| Simple | 96.95 |
| DistX | 81.11 |
| DistS | 84.39 |
| DistF | 91.43 |

Table 2. Probability of Correct Classification using Bayes Classifier.

For each probability density function (*Simple*, *DistX*, *DistS* and *DistF*), $4 \times 3 = 12$ samples (3 for each quantity of examples) with 100, 200, 400 and 800 examples were generated. The SLS training algorithm using 1, 2, 3, and 4 straight line segments for each class was applied to each sample, totalling 192 applications of the training algorithm. The parameters used for training algorithm are shown in Table 3.

| Parameter | Value |
|-----------------|--------|
| I_{max} | 10 000 |
| I_{min} | 20 |
| γ_{init} | 0.1 |
| γ_{inc} | 0.1 |
| γ_{dec} | 0.5 |
| $Desl_{min}$ | 0.001 |
| R_{min} | 0.0001 |

Table 3. Training parameters for the SLS Training Algorithm.

The obtained results for the probability density functions *Simple*, *DistX*, *DistS* and *DistF* are respectively shown in Tables 4, 5, 6 and 7. The rows of these tables present the results using the same number of examples; while the columns show the results with the same number of straight line segments for each class. On left part of each column, it is presented the best result among the three performed tests with the same number of examples and de same number of straight line segments for each class. On right part of each column, it is shown the average of probability of correct classification for the three tests. The results shown in bold have the difference from the respective Bayes correct classification less than 1%.

In Figure 4, there are four response maps, one for each probability density function. In these maps, the gray scale is proportional to $y_{\mathcal{L}}(x) \in [0, 1]$ value, where black represents 0 and white represents 1. In these maps, the straight line segments are projected to a bidimensional plane. For these projections of the straight line segments, white represents class 0 and black class 1. Since the probability density functions are known, we can compute and compare the probability of correct classification of SLS and Bayes classifiers. The results show that the SLS method achieved good performance. For all cases, we obtained a difference that is less than 1% comparing to Bayes classifier.

For distributions *DistS* and *DistF* (that have a more complex decision boundary), it was necessary to add more straight line segments for each class to obtain a good performance. For distributions *Simple* and *DistX*, just one straight line segment for each class was enough for a good performance. As expected, the more training examples, the better performance of the classifier.

4.2 Experiments with Public Datasets

To compare the performance of SLS with other methods, we did experiments using 8 public datasets. These datasets were chosen from (Van Gestel et al., 2004) in which a benchmarking for SVM and other methods can be found. In this way, it is possible to compare our results with theirs (Van Gestel et al., 2004). The datasets taken from (Van Gestel et al., 2004) correspond only to binary classification. All datasets are available in UCI Machine Learning Repository (Asuncion & Newman, 2007) and they are *Australian Credit Approval* (**australian**), *Breast Cancer Wisconsin* (**breast-cancer**), *Pima Indians Diabetes* (**diabetes**), *German Credit Data* (**german**), *Heart* (**heart**), *Ionosphere* (**ionosphere**), *Liver Disorders* (**liver-disorders**) and *Sonar*,

| Simple (Bayes = 96.951 %) | | | | | | | | |
|---------------------------|--------------|--------------|--------------|--------------|--------------|--------------|--------------|--------------|
| # of SLS/class | 1 | | 2 | | 3 | | 4 | |
| | Max. | Avg. | Max. | Avg. | Max. | Avg. | Max. | Avg. |
| 100 | 96.40 | 95.93 | 96.69 | 96.07 | 96.41 | 96.17 | 96.32 | 95.97 |
| 200 | 96.43 | 96.37 | 96.51 | 96.47 | 96.45 | 96.40 | 96.44 | 96.39 |
| 400 | 96.64 | 96.60 | 96.65 | 96.54 | 96.63 | 96.55 | 96.56 | 96.47 |
| 800 | 96.80 | 96.52 | 96.55 | 96.48 | 96.79 | 96.57 | 96.58 | 96.48 |

Table 4. Results for **Simple** pdf.

| DistX (Bayes = 81.105 %) | | | | | | | | |
|--------------------------|--------------|--------------|--------------|--------------|--------------|--------------|--------------|--------------|
| # of SLS/class | 1 | | 2 | | 3 | | 4 | |
| | Max. | Avg. | Max. | Avg. | Max. | Avg. | Max. | Avg. |
| 100 | 78.86 | 78.45 | 78.37 | 77.68 | 76.46 | 76.36 | 78.39 | 77.65 |
| 200 | 80.49 | 80.33 | 79.98 | 79.75 | 79.61 | 79.29 | 79.70 | 79.32 |
| 400 | 80.90 | 80.63 | 80.76 | 80.41 | 80.73 | 80.45 | 80.74 | 79.86 |
| 800 | 81.03 | 80.86 | 80.98 | 80.77 | 81.06 | 80.84 | 80.86 | 80.75 |

Table 5. Results for **DistX** pdf.

| DistS (Bayes = 84.386 %) | | | | | | | | |
|---------------------------|-------|-------|--------------|--------------|--------------|--------------|--------------|--------------|
| # of SLS/class | 1 | | 2 | | 3 | | 4 | |
| | Max. | Avg. | Max. | Avg. | Max. | Avg. | Max. | Avg. |
| 100 | 82.85 | 80.67 | 82.94 | 81.12 | 83.76 | 82.23 | 83.58 | 82.21 |
| 200 | 81.88 | 80.80 | 83.54 | 82.92 | 83.77 | 83.11 | 83.66 | 81.94 |
| 400 | 81.17 | 80.29 | 83.94 | 83.64 | 84.03 | 83.78 | 83.99 | 81.50 |
| 800 | 80.83 | 80.61 | 83.90 | 83.78 | 83.98 | 83.80 | 83.98 | 83.88 |

Table 6. Results for **DistS** pdf.

| DistF (Bayes = 91.435 %) | | | | | | | | |
|--------------------------|-------|-------|--------------|-------|--------------|-------|--------------|--------------|
| # of SLS/class | 1 | | 2 | | 3 | | 4 | |
| | Max. | Avg. | Max. | Avg. | Max. | Avg. | Max. | Avg. |
| 100 | 85.25 | 84.72 | 89.12 | 88.94 | 90.46 | 88.68 | 89.84 | 87.91 |
| 200 | 83.56 | 83.46 | 90.27 | 89.64 | 89.79 | 89.72 | 89.86 | 89.57 |
| 400 | 85.60 | 84.61 | 90.47 | 90.25 | 90.45 | 90.22 | 90.84 | 90.63 |
| 800 | 83.61 | 83.53 | 90.12 | 89.80 | 90.53 | 90.05 | 90.68 | 90.41 |

Table 7. Results for **DistF** pdf.

Mines vs. Rocks (sonar). The number of attributes in each dataset is shown in Table 8. For more detailed information, we recommend to visit the UCI Machine Learning Repository (Asuncion & Newman, 2007).

We performed the experiment using the same methodology described in (Van Gestel et al., 2004), that is, for each training, the sample is randomly split into two sets: one for training containing 2/3 of examples; and other for the test phase with 1/3 of examples. This splitting process is repeated ten times for each dataset. Besides, the training parameters used for training the SLS method were the same values used for artificial data (see Table 3).

Table 8 shows the average and the standard deviation (presented between parenthesis) of correct classification. The results for the SLS method using 1, 2, 3, 4, 6, 8, and 10 straight line segments for each class, respectively, are shown at Rows from 1 to 7. The results obtained by Van Gestel et al. (2004) using SVM and k -NN are presented at Rows from 8 to 17. Finally,

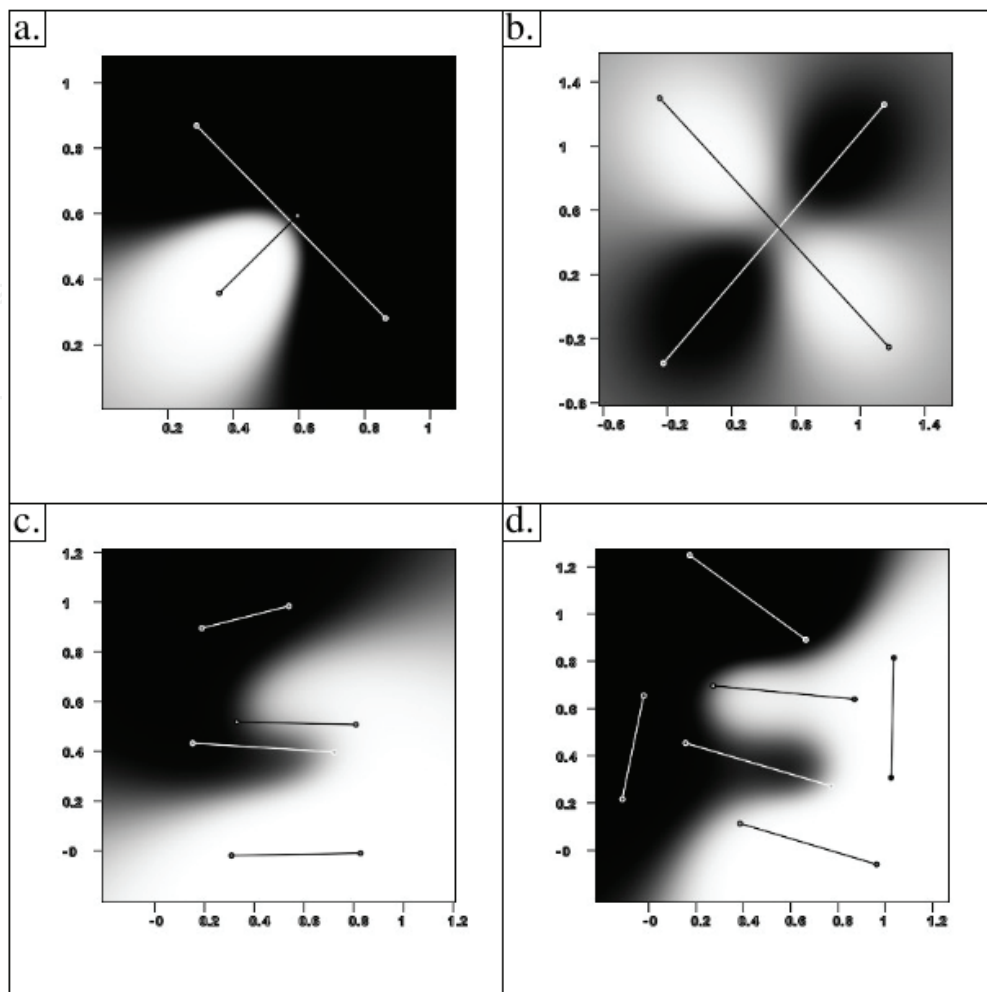


Fig. 4. Response maps for each probability density function:
 a) *Simple*, sample with 800 examples and using 1 straight line segment for each class;
 b) *DistX*, sample with 800 examples and using 1 straight line segment for each class;
 c) *DistS*, sample with 800 examples and using 2 straight line segments for each class;
 d) *DistE*, sample with 400 examples and using 3 straight line segments for each class.

the results using SVM with RBF and polynomial kernels (Eqs. 31 and 32 - in these equations, δ and ρ are kernel parameters and C controls how the errors are penalized) are shown at Rows 18 and 22. In particular, the last two results were obtained using the LibSVM software developed by Chang & Lin (2001) with parameters δ , C and ρ (shown at Rows 20, 21, 24, 25 and 26) chosen by an exhaustive search for the best combination using the values presented in Table 9.

| | | australian | breast-cancer | diabetes | german | heart | ionosphere | liver |
|----|--------------------------|-------------------|-------------------|-------------------|-------------------|-------------------|-------------------|------------|
| | N_{test} | 690 | 683 | 768 | 1000 | 270 | 351 | |
| | d | 14 | 9 | 8 | 20 | 13 | 33 | |
| 1 | SLS 1 | <u>86.7</u> (1.5) | <u>97.7</u> (0.6) | 76.4 (1.8) | 76.4 (1.0) | <u>81.7</u> (4.6) | 94.1 (1.7) | 59.7 (1.5) |
| 2 | SLS 2 | <u>86.3</u> (1.9) | <u>97.8</u> (0.7) | 74.8 (2.5) | 76.7 (2.2) | 80.6 (3.9) | 94.6 (1.4) | 60.1 (1.6) |
| 3 | SLS 3 | <u>86.5</u> (1.7) | <u>98.1</u> (0.8) | 74.2 (2.0) | <u>75.9</u> (2.1) | <u>81.7</u> (3.6) | <u>94.4</u> (2.1) | 70.1 (1.7) |
| 4 | SLS 4 | <u>86.3</u> (1.8) | 98.1 (0.7) | 73.7 (1.7) | <u>76.3</u> (1.4) | <u>81.9</u> (3.3) | 93.4 (3.1) | 70.1 (1.7) |
| 5 | SLS 6 | <u>86.1</u> (1.6) | <u>98.0</u> (0.7) | 72.4 (2.9) | <u>76.5</u> (1.6) | 81.0 (2.8) | 94.9 (1.3) | 63.1 (1.6) |
| 6 | SLS 8 | 87.0 (1.8) | <u>97.9</u> (0.8) | 72.4 (2.4) | <u>76.2</u> (1.6) | 81.4 (3.4) | <u>94.8</u> (1.6) | 60.1 (1.6) |
| 7 | SLS 10 | <u>86.8</u> (1.8) | <u>97.8</u> (0.7) | 72.2 (3.2) | <u>76.4</u> (1.6) | 82.2 (3.3) | 95.2 (2.6) | 60.1 (1.6) |
| 8 | RBFLS – SVM | 87.0 (2.1) | 96.4 (1.0) | 76.8 (1.7) | 76.3 (1.4) | 84.7 (4.8) | 96.0 (2.1) | 70.1 (1.7) |
| 9 | RBFLS – SVM _F | 86.4 (1.9) | 96.8 (0.7) | 72.9 (2.0) | 70.8 (2.4) | 83.2 (5.0) | 93.4 (2.7) | 60.1 (1.6) |
| 10 | LinLS – SVM | 86.8 (2.2) | 95.8 (1.0) | 76.8 (1.8) | 75.4 (2.3) | 84.9 (4.5) | 87.9 (2.0) | 60.1 (1.6) |
| 11 | LinLS – SVM _F | 86.5 (2.1) | 96.9 (0.7) | 73.1 (1.7) | 68.6 (2.3) | 82.8 (4.4) | 85.0 (3.5) | 60.1 (1.6) |
| 12 | PolLS – SVM | 86.5 (2.2) | 96.4 (0.9) | 77.0 (1.8) | 76.3 (1.4) | 83.7 (3.9) | 91.0 (2.5) | 70.1 (1.7) |
| 13 | PolLS – SVM _F | 86.6 (2.2) | 96.9 (0.7) | 73.0 (1.8) | 70.3 (2.3) | 82.4 (4.6) | 91.7 (2.6) | 60.1 (1.6) |
| 14 | RBFSVM | 86.3 (1.8) | 96.4 (1.0) | 77.3 (2.2) | 75.9 (1.4) | 84.7 (4.8) | 95.4 (1.7) | 70.1 (1.7) |
| 15 | LinSVM | 86.7 (2.4) | 96.3 (1.0) | 77.0 (2.4) | 75.4 (1.7) | 83.2 (4.2) | 87.1 (3.4) | 60.1 (1.6) |
| 16 | 1 – NN | 81.1 (1.9) | 95.3 (1.1) | 69.6 (2.4) | 69.3 (2.6) | 74.3 (4.2) | 87.2 (2.8) | 60.1 (1.6) |
| 17 | 10 – NN | 86.4 (1.3) | 96.4 (1.2) | 73.6 (2.4) | 72.6 (1.7) | 80.0 (4.3) | 85.9 (2.5) | 60.1 (1.6) |
| 18 | libSVMRBF | 87.4 (1.6) | 97.8 (0.5) | 77.8 (1.8) | 77.3 (0.5) | 85.1 (3.3) | 95.4 (1.9) | 70.1 (1.7) |
| 19 | # SV | 407.7 | 46 | 277.9 | 371.9 | 145.8 | 65.6 | |
| 20 | γ | 0.01 | 0.01 | 0.01 | 0.01 | 0.1 | 0.1 | |
| 21 | C | 0.1 | 10 | 50 | 20 | 0.1 | 10 | |
| 22 | libSVMPol | 87.3 (1.7) | 97.9 (0.9) | 77.3 (2.2) | 76.4 (1.4) | 82.4 (4.0) | 92.8 (2.6) | 70.1 (1.7) |
| 23 | # SV | 158.9 | 52.8 | 277.2 | 386.5 | 143.2 | 78.3 | |
| 24 | δ | 2 | 0.01 | 5 | 0.01 | 0.01 | 2 | |
| 25 | C | 0.01 | 200 | 0.01 | 50 | 20 | 0.01 | |
| 26 | ϱ | 2 | 2 | 2 | 2 | 2 | 2 | |

The results presented in this table are the average of correct classification for 10 tests. The number in parentheses is the standard deviation. For each column there are two values in bold: the first one is the best result using SLS method and second one is the best result among the other methods. The underlined numbers for the SLS method are statistically equal to the best results among the other methods.

Table 8. Average of Correct classification for public datasets.

$$K(x_i, x_j) = e^{-\delta \|x_i - x_j\|^2} \tag{31}$$

$$K(x_i, x_j) = \left(\delta \langle x_i, x_j \rangle \right)^q \tag{32}$$

| | |
|----------|-------------------------------------|
| C | 0.01, 0.1, 10, 20, 50, 100, 200 |
| δ | 0.01, 0.1, 0.5, 1.0, 2.0, 5.0, 10.0 |
| q | 2, 4, 6, 8, 10 |

Table 9. Parameters for RFB and Polynomial Kernels (Eqs. 31 and 32).

In order to have a good view of the results, the average of correct classification for each dataset can also be viewed in the plots presented in Figure 5.

By observing the plots in Figure 5, we can see that the good performance of SLS method with respect to the others is well-posted on the graphic of the breast-cancer dataset. More details about the results can be viewed on Table 8. In particular, this table is divided in two blocks: the first one presents the results of the SLS method (Rows from 1 to 7); while the second one shows the results using SVM and k -NN taken from (Van Gestel et al., 2004). The best results in each block are in bold. We also applied the t-test with 95% of confidence (Dietterich, 1998) to the results of the SLS method and the best result of SVM and k -NN. The underlined values in the table indicate that the results obtained by SLS method are statistically equal to the best result among the others. By observing Table 8, it is possible to notice that by t-test the SLS method has always the performance significantly equal to the performance of SVM. In the case of **breast-cancer** dataset, the performance of SLS method was better than SVM.

On one hand, the computational time complexity of SVM on test phase is $\Theta(N_{SV} \cdot K)$, where N_{SV} is the number of support vectors and K is the computational complexity for computing the kernel (Burges, 1998). The time complexity for both polynomial and RBF kernel computations is proportional to distance computations. On the other hand, the computational time complexity of the SLS method on test phase is $\Theta(|L_0| + |L_1|)$. Note that, for each straight line segment, there are two distance computations. Then, with respect to the computational complexity, one straight line segment in SLS is equivalent to two support vectors in SVM.

In the experiments presented in this chapter, for the SLS method, we used no more than 10 straight line segments for each class meaning the maximum of 20 straight line segments. This is equivalent to 40 support vectors in SVM. Note that, at Rows 19 and 23 in Table 8, the lowest average of support vectors is 46 in breast-cancer dataset with RBF kernel. However, in general, the number of support vectors is commonly higher than it. Therefore, comparing the computational complexity of both methods, we can conclude that the SLS method is computationally more efficient than SVM for similar classification performance. □



Fig. 5. Graphics showing the average of correct classification for public datasets.

5. Conclusion

In this chapter we presented a new method for Pattern Recognition based on distance between points and straight line segments called SLS method. Although the design of the SLS method was not initially based on any other method, it has some similarities to the Learning Vector Quantization (LVQ) and the Nearest Feature Line (NFL) methods so that SLS can take the advantages of both methods. For instance, SLS has the low computational complexity of LVQ and the interpolation capacity of straight lines of NFL. The experiments presented here confirm these advantages showing that the SLS method has lower computational complexity than SVM on the test phase with similar classification performance. By observing these results, we can conclude that the SLS method is a new and good option for supervised pattern recognition systems.

The SLS method also opens new perspectives for future research on Pattern Recognition. One of the main interest is to improve the training algorithm (which outputs a local optimal solution) by solving the underlying nonlinear optimization problem using other methods than gradient descent (for example, genetic algorithms). Other topics of interest are to extend the method for multiclassification and regression problems.

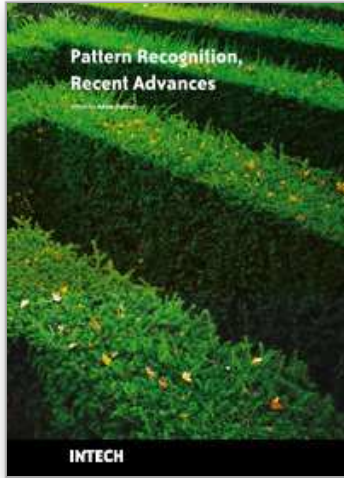
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